

# STTH1R06

# TURBO 2 ULTRAFAST HIGH VOLTAGE RECTIFIER

**Table 1: Main Product Characteristics** 

I <sub>F(AV)</sub>	1 A
V <sub>RRM</sub>	600 V
I <sub>R</sub> (max)	75 μ <b>A</b>
T <sub>j</sub>	175°C
V <sub>F</sub> (typ)	1.0 V
t <sub>rr</sub> (max)	25 ns

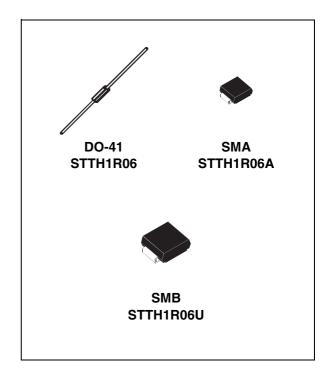
#### **FEATURES AND BENEFITS**

- Ultrafast switching
- Low reverse recovery current
- Low thermal resistance
- Reduces switching & conduction losses

### **DESCRIPTION**

The STTH1R06, which is using ST Turbo 2 600V technology, is specially suited as boost diode in power factor correction circuitry.

The device is also intended for use as a free wheeling diode in power supplies and other power switching applications.



**Table 2: Order Codes** 

Part Number	Marking
STTH1R06	STTH1R06
STTH1R06RL	STTH1R06

Part Number	Marking
STTH1R06A	HR6
STTH1R06U	BR6

Table 3: Absolute Ratings (limiting values)

Symbol	Р	Value	Unit		
$V_{RRM}$	Repetitive peak reverse voltage	е		600	٧
I <sub>F(RMS)</sub>	RMS forward voltage	DO-41		10	Α
		SMA / SMB		7	
I <sub>F(AV)</sub>	Average forward current	DO-41	$Tc = 100^{\circ}C$ $\delta = 0.5$		
		SMA	$Tc = 125^{\circ}C$ $\delta = 0.5$	1	Α
		SMB	$Tc = 135^{\circ}C$ $\delta = 0.5$		
I <sub>FSM</sub>	Surge non repetitive forward	DO-41	tp = 10ms sinusoidal	25	Α
	current	SMA / SMB	tp = Toms sinusoidai	20	
T <sub>stg</sub>	Storage temperature range	-65 to + 175	°C		
T <sub>j</sub>	Maximum operating junction temperature			175	°C

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**Table 4: Thermal Resistance** 

Symbol	Parameter			Value (max).	Unit
R <sub>th(j-l)</sub>	Junction to lead	L = 10mm	DO-41	45	°C/W
			SMA	30	
			SMB	25	
R <sub>th(j-a)</sub>	Junction to ambient (1)	L = 10mm	DO-41	70	°C/W

Note 1:  $R_{th(j-a)}$  is measured with a copper area  $S = Scm^2$  (see figure 12).

**Table 5: Static Electrical Characteristics** 

Symbol	Parameter	Test conditions		Min.	Тур	Max.	Unit
I <sub>R</sub>	Reverse leakage current	T <sub>j</sub> = 25°C	$V_R = V_{RRM}$			1	μΑ
		T <sub>j</sub> = 150°C			10	75	
V <sub>F</sub>	Forward voltage drop	T <sub>j</sub> = 25°C	I <sub>F</sub> = 1A			1.7	V
		T <sub>j</sub> = 150°C			1.0	1.25	

To evaluate the conduction losses use the following equation:  $P = 1.03 \times I_{F(AV)} + 0.27 I_{F}^{2} (RMS)$ 

**Table 6: Dynamic Characteristics** 

Symbol	Parameter	Test conditions			Тур	Max.	Unit
t <sub>rr</sub>	Reverse recovery	T <sub>j</sub> = 25°C	$I_F = 0.5A$ $Irr = 0.25A$ $I_R = 1A$			25	ns
	time		$I_F = 1A dI_F/dt = -50 A/\mu s V_R = 30V$		30	45	
t <sub>fr</sub>	Forward recovery time	T <sub>j</sub> = 25°C	$I_F = 1A$ $dI_F/dt = 100 A/\mu s$ $V_{FR} = 1.1 \times V_{Fmax}$			100	ns
V <sub>FP</sub>	Forward recovery voltage	T <sub>j</sub> = 25°C	$I_F = 1A$ $dI_F/dt = 100 A/\mu s$ $V_{FR} = 1.1 \times V_{Fmax}$			10	V

Figure 1: Conduction losses versus average forward current

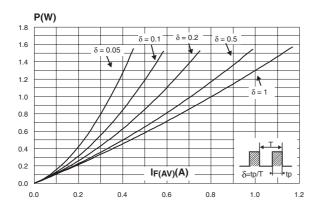


Figure 3: Relative variation of thermal impedance junction to case versus pulse duration (DO-41)

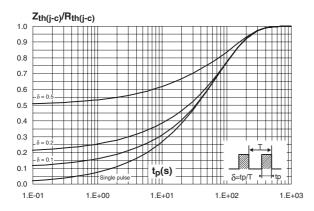


Figure 5: Relative variation of thermal impedance junction to case versus pulse duration (SMB)

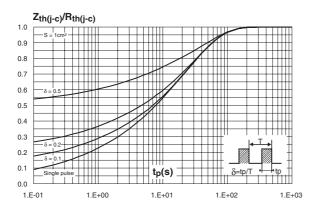


Figure 2: Forward voltage drop versus forward current

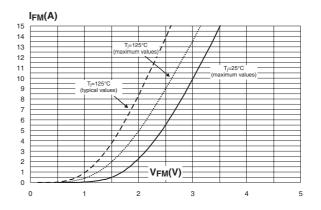


Figure 4: Relative variation of thermal impedance junction to case versus pulse duration (SMA)

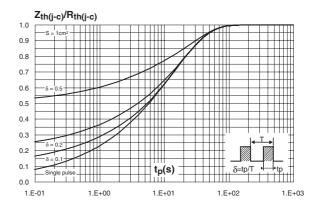


Figure 6: Peak reverse recovery current versus dl<sub>F</sub>/dt (typical values)

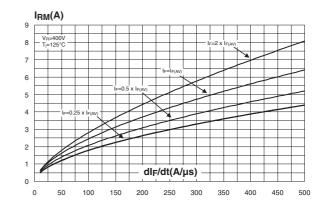


Figure 7: Reverse recovery time versus dl<sub>F</sub>/dt (typical values)

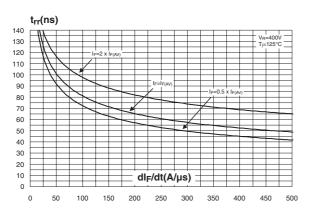


Figure 9: Reverse recovery softness factor versus dl<sub>F</sub>/dt (typical values)

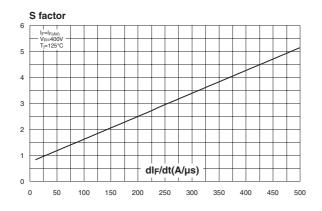


Figure 11: Transient peak forward voltage versus dl<sub>F</sub>/dt (typical values)

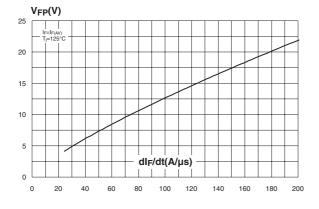


Figure 8: Reverse recovery charges versus dI<sub>F</sub>/dt (typical values)

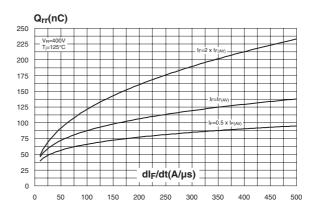


Figure 10: Relative variations of dynamic parameters versus junction temperature

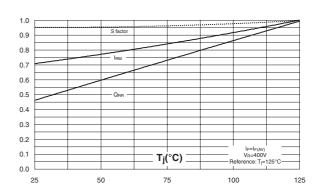


Figure 12: Forward recovery time versus  $dI_F/dt$  (typical values)

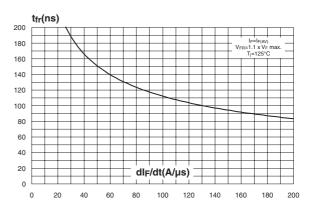


Figure 13: Junction capacitance versus reverse voltage applied (typical values)

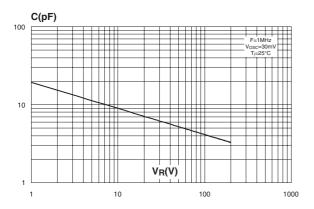


Figure 15: Thermal resistance junction to ambient versus copper surface under each lead (epoxy FR4,  $e_{CU}$ =35 $\mu$ m) (SMA)

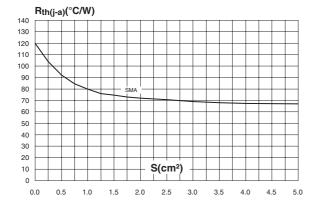


Figure 14: Thermal resistance junction to ambient versus copper surface under each lead (epoxy FR4, e<sub>CU</sub>=35µm) (DO-41, SMB)

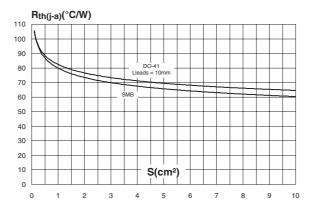
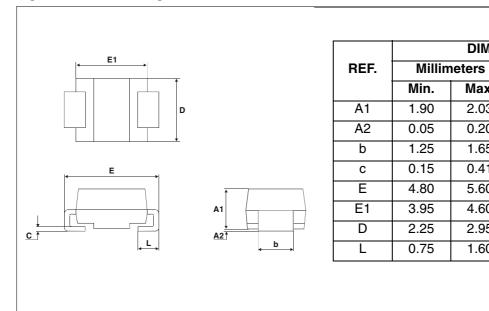


Figure 16: SMA Package Mechanical Data



**DIMENSIONS** 

Max.

2.03

0.20

1.65

0.41

5.60

4.60

2.95

1.60

Inches

Max.

0.080

0.008

0.065

0.016

0.220

0.181

0.116

0.063

Min.

0.075

0.002

0.049

0.006

0.189

0.156

0.089

0.030

Figure 17: SMA Foot Print Dimensions (in millimeters)

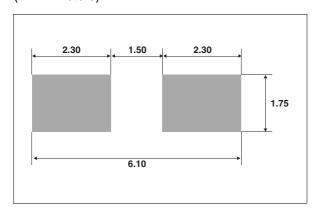
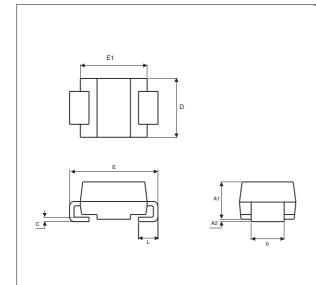


Figure 18: SMB Package Mechanical Data



		DIMEN	ISIONS	
REF.	Millin	neters	Inc	hes
	Min.	Max.	Min.	Max.
A1	1.90	2.45	0.075	0.096
A2	0.05	0.20	0.002	0.008
b	1.95	2.20	0.077	0.087
С	0.15	0.41	0.006	0.016
E	5.10	5.60	0.201	0.220
E1	4.05	4.60	0.159	0.181
D	3.30	3.95	0.130	0.156
L	0.75	1.60	0.030	0.063

Figure 19: SMB Foot Print Dimensions (in millimeters)

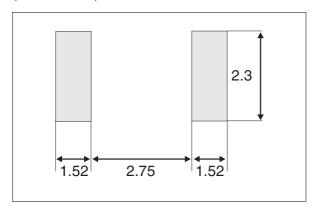
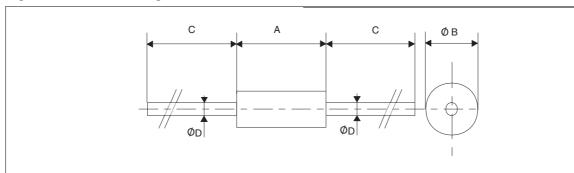


Figure 20: DO-41 Package Mechanical Data



	DIMENSIONS					
REF.	Millin	Millimeters		hes		
	Min.	Max.	Min.	Max.		
Α	4.07	5.20	0.160	0.205		
В	2.04	2.71	0.080	0.107		
С	28		1.102			
D	0.712	0.863	0.028	0.034		

**Table 7: Ordering Information** 

Ordering type	Marking	Package	Weight	Base qty	Delivery mode
STTH1R06	STTH1R06	DO-41	0.34 g	2000	Ammopack
STTH1R06RL	STTH1R06	DO-41	0.34 g	5000	Tape & reel
STTH1R06A	AR6	SMA	0.068 g	5000	Tape & reel
STTH1R06B	BR6	SMB	0.11 g	2500	Tape & reel

■ Epoxy meets UL94, V0

**Table 8: Revision History** 

Date	Revision	Description of Changes
Apr-2003	1	First issue
07-Sep-2004	2	DO-41 and SMA packages added
24-Feb-2005	3	SMA package dimensions update. Reference A1 max. changed from 2.70mm (0.106inc.) to 2.03mm (0.080).

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